

**Notice of References Cited**

Application/Control No.

10/789,666

Applicant(s)/Patent Under  
Reexamination  
FONG ET AL.

Examiner

Jeremy Bukowczyk

Art Unit

3609

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0193420 a1	09-2004	Kennewick et al.	704/257
*	B	US-2002/0165667 a1	11-2002	Lee, Eun-Hee	701/211
*	C	US-2003/0145338 a1	07-2003	Harrington, Jeffrey M.	725/136
*	D	US-2002/0020750 a1	02-2002	Dymetman et al.	235/472.01
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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